

a	b	c	d	e= f(d,k)	f	g	h = cxf/e	i = cxg/e	k
Uncertainty Component	Sec.	Tol. ( $\pm$ %)	Prob. Dist.	Div.	$c_i$ $(1 - g)$	$c_i$ $(10 - g)$	$1 - g$ $u_i$ ( $\pm$ %)	$10 - g$ $u_i$ ( $\pm$ %)	$v_i$
<b>Measurement System</b>									
Probe Calibration	E1.1	3.0	N	1	1	1	6.2	6.2	$\infty$
Axial Isotropy	E1.2	4.88	R	$\sqrt{3}$	$(1 - cp)^{1/2}$	$(1 - cp)^{1/2}$	2.0	2.0	$\infty$
Hemispherical Isotropy	E1.2	9.6	R	$\sqrt{3}$	$\sqrt{c_p}$	$\sqrt{c_p}$	3.9	3.9	$\infty$
Boundary Effect	E1.3	11.0	R	$\sqrt{3}$	1	1	6.4	6.4	$\infty$
Linearity	E1.4	4.7	R	$\sqrt{3}$	1	1	2.7	2.7	$\infty$
System Detection Limits	E1.5	1.0	R	$\sqrt{3}$	1	1	0.6	0.6	$\infty$
Readout Electronics	E1.6	1.0	R	1	1	1	1.0	1.0	$\infty$
Response Time	E1.7	0.8	R	$\sqrt{3}$	1	1	0.3	0.3	$\infty$
Integration Time	E1.8	1.7	R	$\sqrt{3}$	1	1	1.0	1.0	$\infty$
RF Ambient Conditions	E5.1	1.2	R	$\sqrt{3}$	1	1	0.7	0.7	$\infty$
Probe Positioner Mechanical Tolerance	E5.2	0.4	R	$\sqrt{3}$	1	1	0.2	0.2	$\infty$
Probe Positioning w/ respect to Phantom Shell	E5.3	2.9	R	$\sqrt{3}$	1	1	1.7	1.7	$\infty$
Extrapolation, Interpolation & Integration Algorithms for Max. SAR Evaluation	E4.2	3.9	R	$\sqrt{3}$	1	1	2.3	2.3	$\infty$
<b>Test Sample Related</b>									
Test Sample Positioning	E3.2.1		R	$\sqrt{3}$	1	1	6.0	6.0	11
Device Holder Uncertainty	E3.1.1		R	$\sqrt{3}$	1	1	5.0	5.0	8
Output Power Variation - SAR drift measurement	5.6.2	5.0	R	$\sqrt{3}$	1	1	2.9	2.9	$\infty$
<b>Phantom &amp; Tissue Parameters</b>									
Phantom Uncertainty (Shape & Thickness tolerances)	E2.1	4.0	R	$\sqrt{3}$	1	1	2.3	2.3	$\infty$
Liquid Conductivity - deviation from target values	E2.2	5.0	R	$\sqrt{3}$	0.7	0.5	2.0	1.4	$\infty$
Liquid Conductivity - measurement uncertainty	E2.2	10.0	R	$\sqrt{3}$	0.7	0.5	4.0	2.9	$\infty$
Liquid Permittivity - deviation from target values	E2.2	5.0	R	$\sqrt{3}$	0.6	0.5	1.7	1.4	$\infty$
Liquid Permittivity - measurement uncertainty	E2.2	5.0	R	$\sqrt{3}$	0.6	0.5	1.7	1.4	$\infty$
<b>Combined Standard Uncertainty (k=1)</b>			RSS				14.7	14.4	
<b>Expanded Uncertainty (k=2)</b> (95% CONFIDENCE LEVEL)							29.4	28.7	

The above measurement uncertainties are according to IEEE Std. 1528-200x (July, 2001)